

30V Complementary MOSFET

DESCRIPTION

The SMC4549M is the N+P channel complementary mode power field effect transistors, using trench technology provide excellent RDS(ON) and low gate charge high current capability.

PART NUMBER INFORMATION

SMC 4549 M - TR G

a : Company name.
b : Product Serial number.
c : Package code M:SOP-8
d : Handling code TR:Tape&Reel
e : Green produce code G:RoHS Compliant

FEATURES

N-Channel

$V_{DS}=30V, \quad I_D=7.8A$

$R_{DS(ON)} = 16m\Omega$ (Typ.) @ $V_{GS} = 10V$

$R_{DS(ON)}=20m\Omega(Typ.)@V_{GS}=4.5V$

P-Channel

$V_{DS} = -30V$, $I_D = -7A$

$R_{DS(ON)}=20m\Omega$ (Typ.)@ $V_{GS}=-10V$

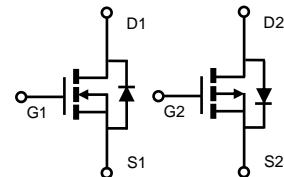
$$R_{DS(ON)}=26m\Omega(Typ.)@V_{GS}=-4.5V$$

APPLICATIONS

- ◆ Load Switch.
 - ◆ Battery Protection Management



SOP-8



N-ch P-ch

■ ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Rating		Units	
		N-ch	P-ch		
V _{DSS}	Drain-Source Voltage	30	-30	V	
V _{GSS}	Gate-Source Voltage	±20	±20	V	
I _D	Continuous Drain Current	T _A =25°C	7.8	-7	A
		T _A =70°C	6.4	-5.8	A
I _{DM}	Pulsed Drain Current ^A		31.2	-28	A
I _{AS}	Avalanche Current ^A		15	-20	A
E _{AS}	Single Pulse Avalanche energy L=0.3mH ^{AF}		33	60	mJ
P _D	Power Dissipation ^B	T _A =25°C	2	2	W
		T _A =70°C	1.3	1.3	W
T _J	Operation Junction Temperature		-55/150		°C
T _{STG}	Storage Temperature Range		-55/150		°C

THERMAL RESISTANCE

Symbol	Parameter		Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^B	$t \leq 10s$		62	°C/W
	Thermal Resistance Junction to Ambient ^{BD}	Steady-State		90	

■N-ch ELECTRICAL CHARACTERISTICS($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	30			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1	1.5	2	V	
I_{GSS}	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$		1		μA	
		$V_{DS}=24\text{V}, V_{GS}=0\text{V}, T_J=75^\circ\text{C}$		10			
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^D	$V_{GS}=10\text{V}, I_D=8\text{A}$		16	20	$\text{m}\Omega$	
		$V_{GS}=4.5\text{V}, I_D=6\text{A}$		20	26		
G_f	Forward Transconductance	$V_{DS}=10\text{V}, I_D=6\text{A}$		6		S	
Diode Characteristics							
V_{SD}	Diode Forward Voltage ^D	$I_S=1\text{A}, V_{GS}=0\text{V}$			1	V	
I_S	Diode Continuous Forward Current				8	A	
t_{rr}	Reverse Recovery Time	$I_S=6\text{A}, dI/dt=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$		12.5		ns	
Q_{rr}	Reverse Recovery Charge			3.2		nC	
Dynamic and Switching Parameters ^E							
Q_g	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_D=6\text{A}$		12.7	17.8	nC	
Q_g	Total Gate Charge (4.5V)			6.2	8.7		
Q_{gs}	Gate-Source Charge			2.4	3.4		
Q_{gd}	Gate-Drain Charge			2	2.8		
C_{iss}	Input Capacitance	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		550		pF	
C_{oss}	Output Capacitance			78			
C_{rss}	Reverse Transfer Capacitance			62			
R_g	Gate Resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, F=1\text{MHz}$		2.4		Ω	
$t_{d(on)}$	Turn-On Time	$V_{DD}=15\text{V}, V_{GEN}=10\text{V}, R_G=3.3\Omega, I_D=1\text{A}$		2.5	5	nS	
				7.6	14		
$t_{d(off)}$	Turn-Off Time			19.8	38		
				4.2	8		

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

- A. Surface mounted on FR4 board using 1 in² pad size.
- B. Pulsed width limited by maximum junction temperature, $T_{J(\text{MAX})}=150^\circ\text{C}$.
- C. Using $\leq 10\text{s}$ junction-to-ambient thermal resistance is base on $T_{J(\text{MAX})}=150^\circ\text{C}$.
- D. Pulse test width $\leq 300\mu\text{s}$ and duty cycle $\leq 2\%$.
- E. Guaranteed by design, not subject to production testing.

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P-ch ELECTRICAL CHARACTERISTICS($T_A = 25^\circ\text{C}$ Unless otherwise noted)

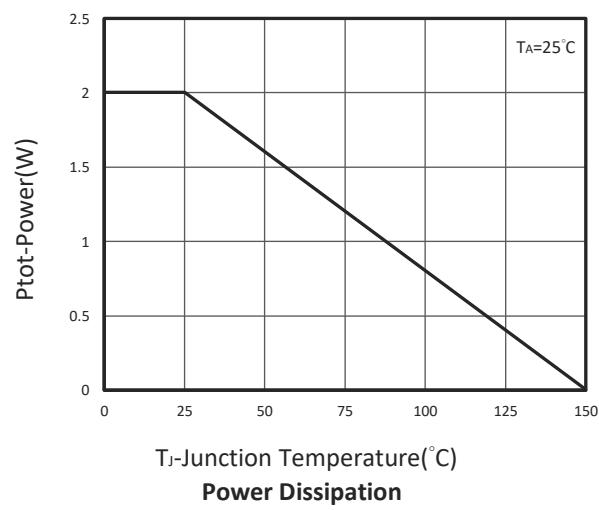
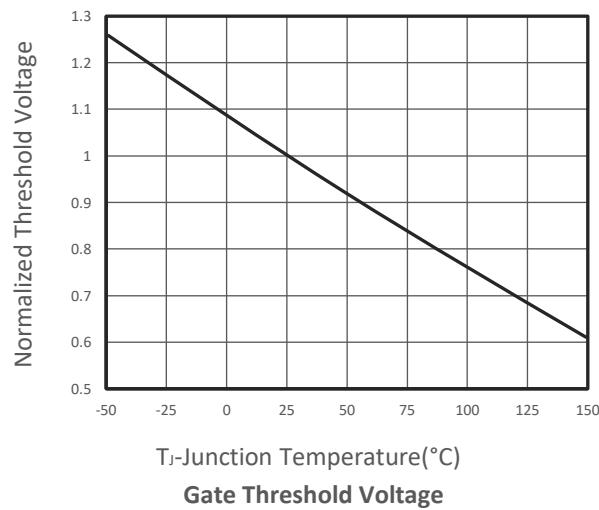
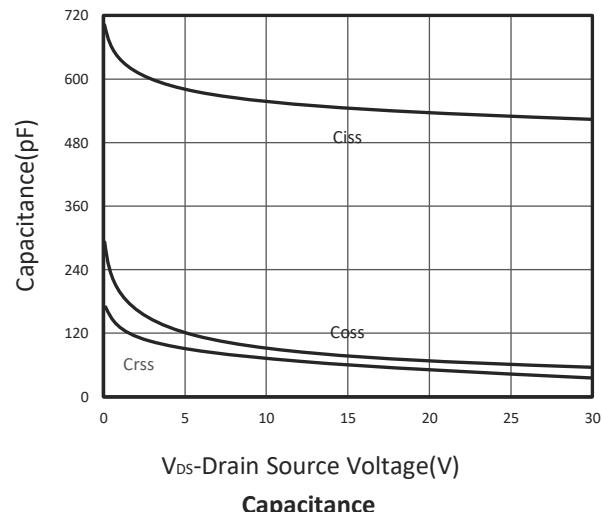
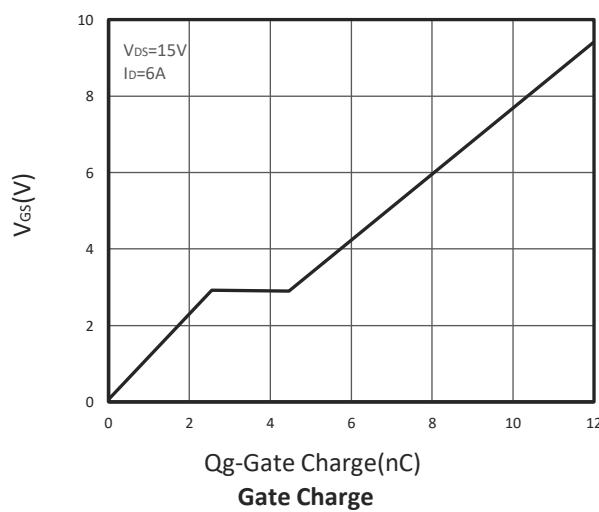
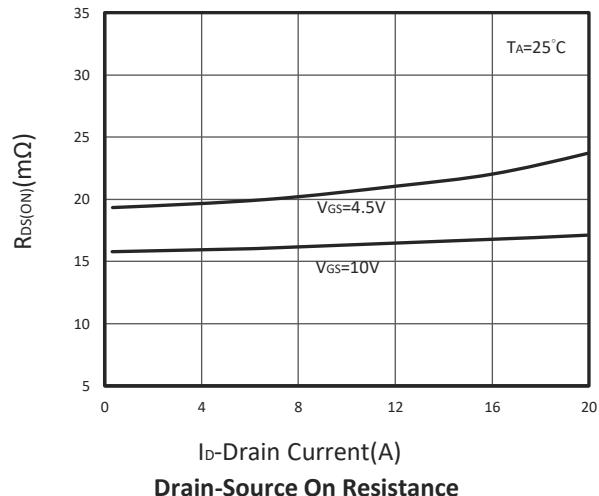
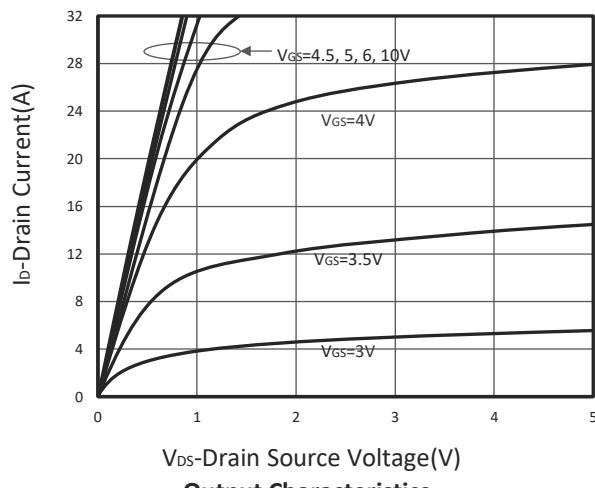
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-30			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1	-1.6	-2.5	V	
I_{GSS}	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-30\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$		-1		μA	
		$V_{DS}=-24\text{V}, V_{GS}=0\text{V}, T_J=75^\circ\text{C}$		-10			
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^D	$V_{GS}=-10\text{V}, I_D=-7\text{A}$		20	25	$\text{m}\Omega$	
		$V_{GS}=-4.5\text{V}, I_D=-5.6\text{A}$		26	32		
G_f	Forward Transconductance	$V_{DS}=-10\text{V}, I_D=-7\text{A}$		12.5		S	
Diode Characteristics							
V_{SD}	Diode Forward Voltage ^D	$I_S=-1\text{A}, V_{GS}=0\text{V}$			-1	V	
I_S	Diode Continuous Forward Current				-7	A	
t_{rr}	Reverse Recovery Time	$I_S=-7\text{A}, dI/dt=100\text{A}/\mu\text{s}$		11		ns	
Q_{rr}	Reverse Recovery Charge			5.8		nC	
Dynamic and Switching Parameters^E							
Q_g	Total Gate Charge	$V_{DS}=-15\text{V}, V_{GS}=-10\text{V}, I_D=-7\text{A}$		23.6	33	nC	
Q_g	Total Gate Charge (4.5V)			11.5	16.1		
Q_{gs}	Gate-Source Charge			4.2	5.9		
Q_{gd}	Gate-Drain Charge			4.4	6.2		
C_{iss}	Input Capacitance	$V_{DS}=-15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		1280		pF	
C_{oss}	Output Capacitance			175			
C_{rss}	Reverse Transfer Capacitance			125			
$t_{d(on)}$	Turn-On Time	$V_{DD}=-15\text{V}, V_{GEN}=-10\text{V}, R_G=3.3\Omega, I_D=-1\text{A}$		6.1	12	nS	
t_r				14	27		
$t_{d(off)}$	Turn-Off Time			34	65		
t_f				13.2	25		

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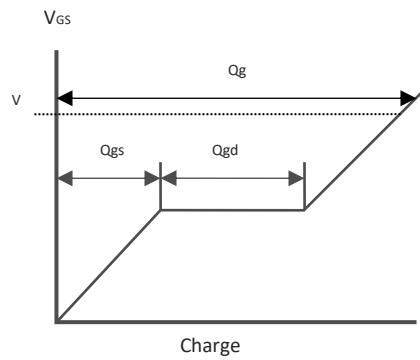
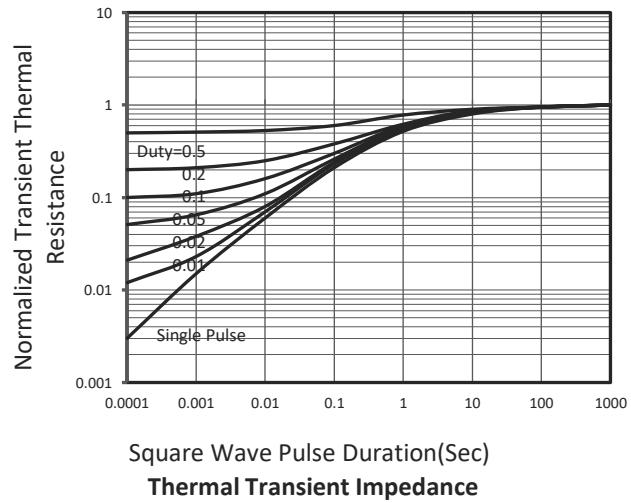
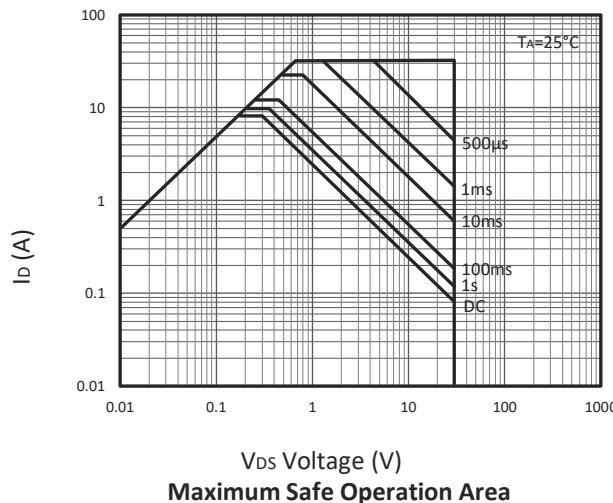
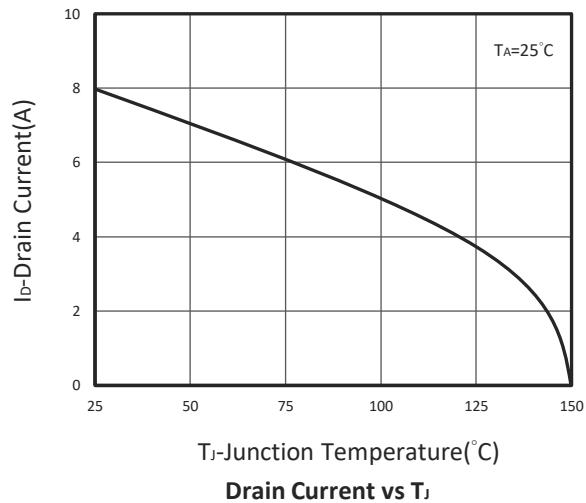
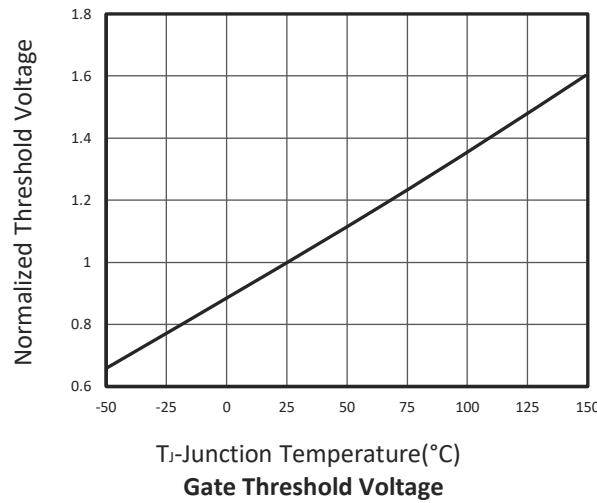
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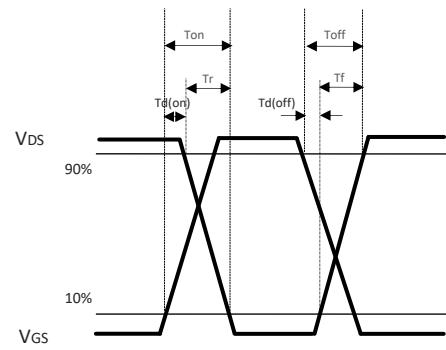
N-ch TYPICAL CHARACTERISTICS



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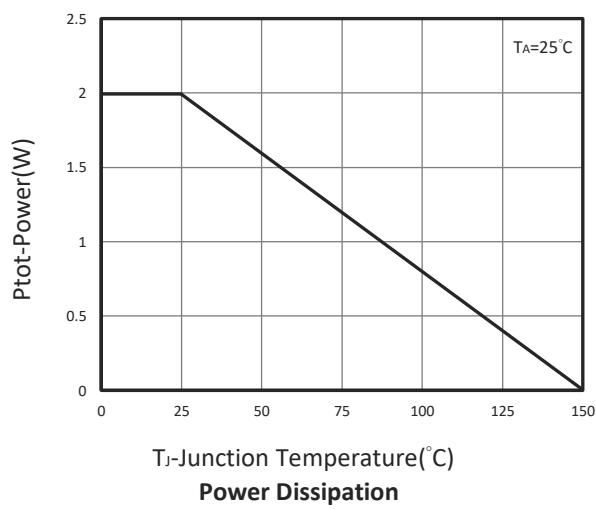
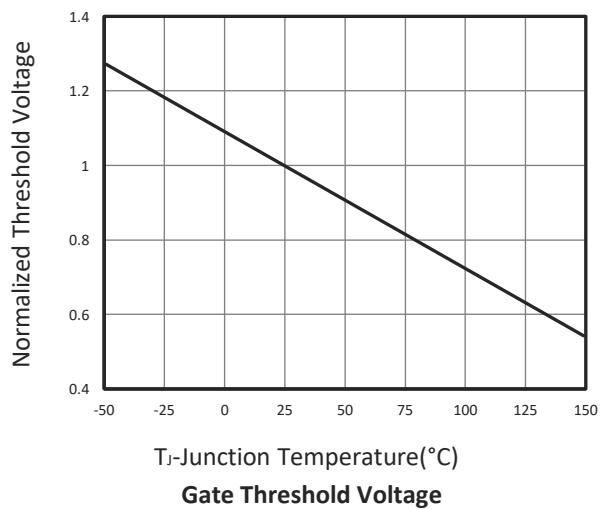
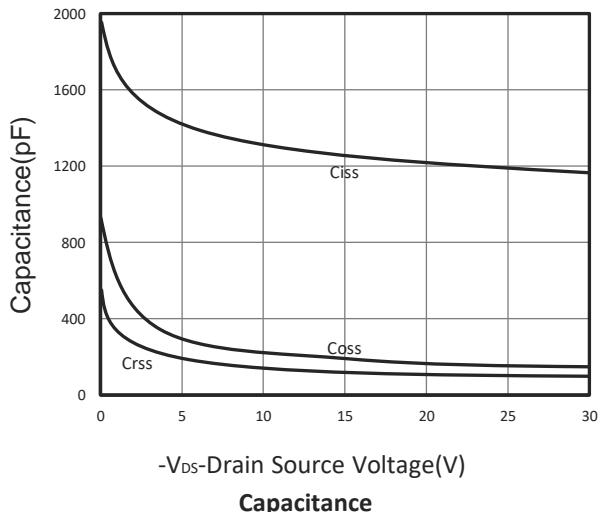
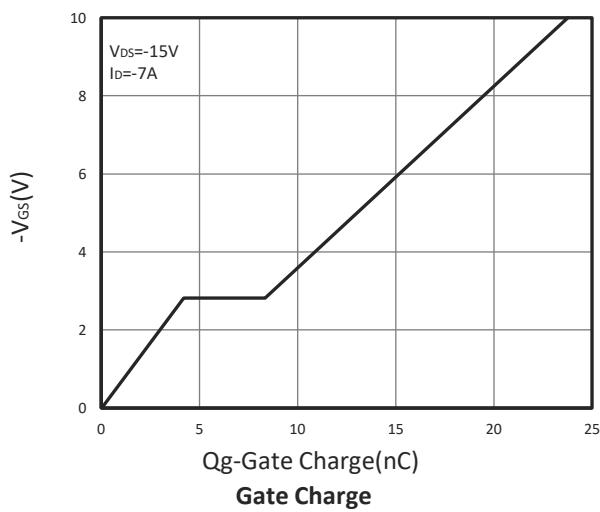
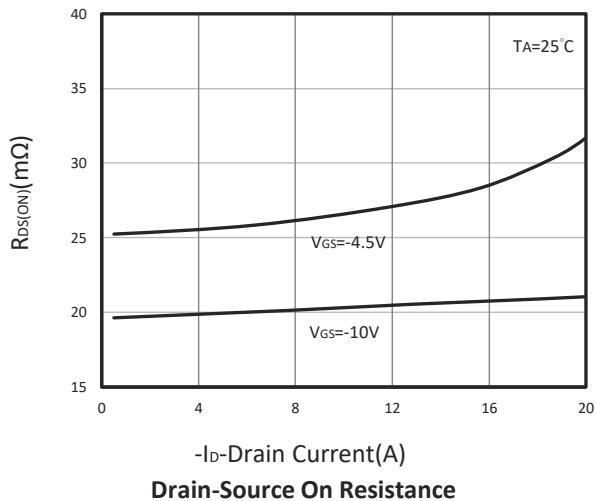
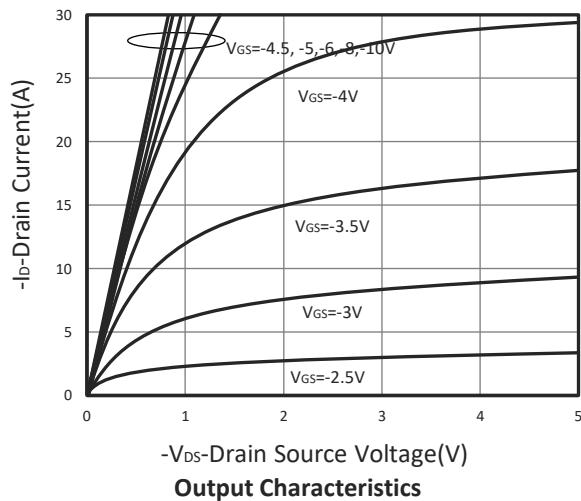


Gate Charge Waveform

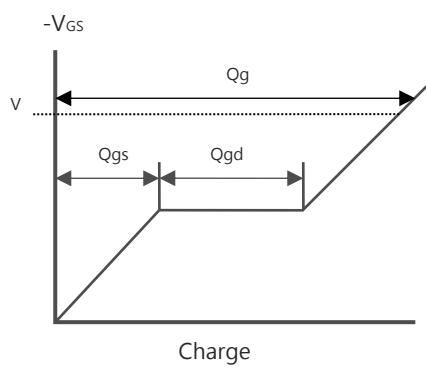
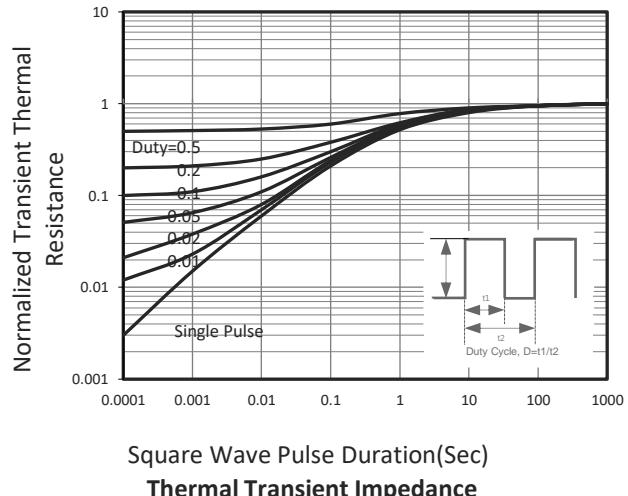
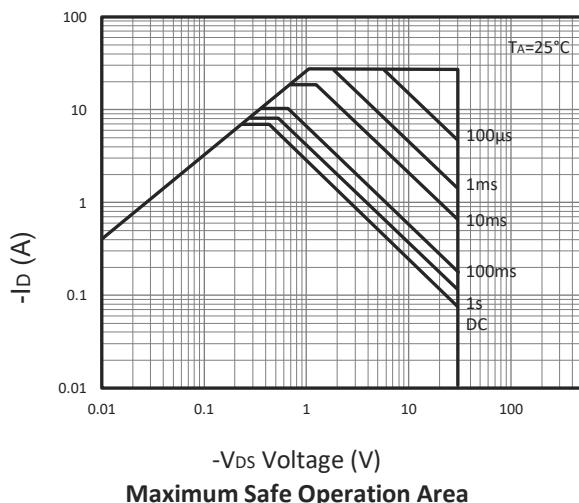
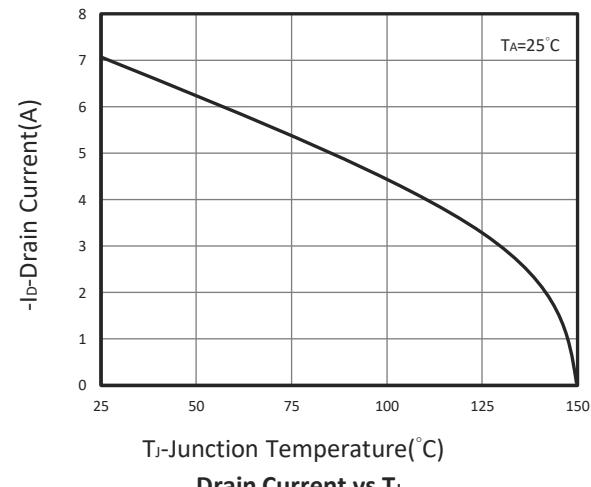
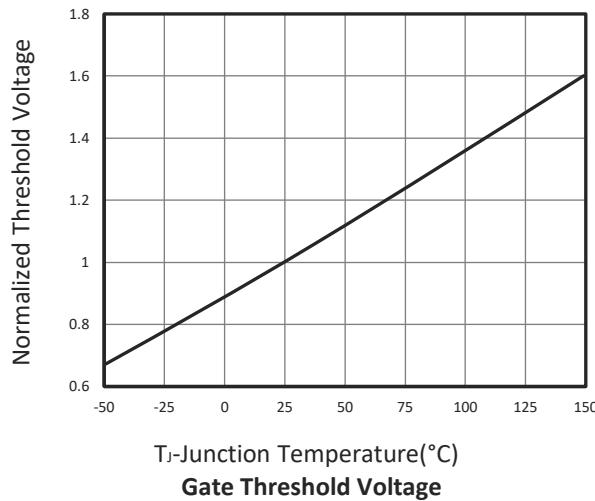


Switching Time Waveform

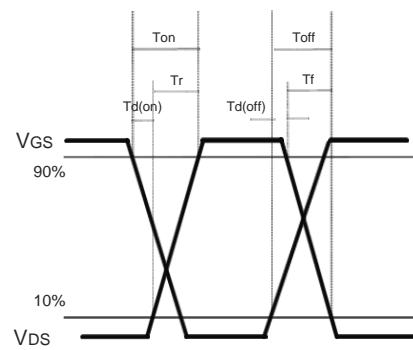
■ P-ch TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

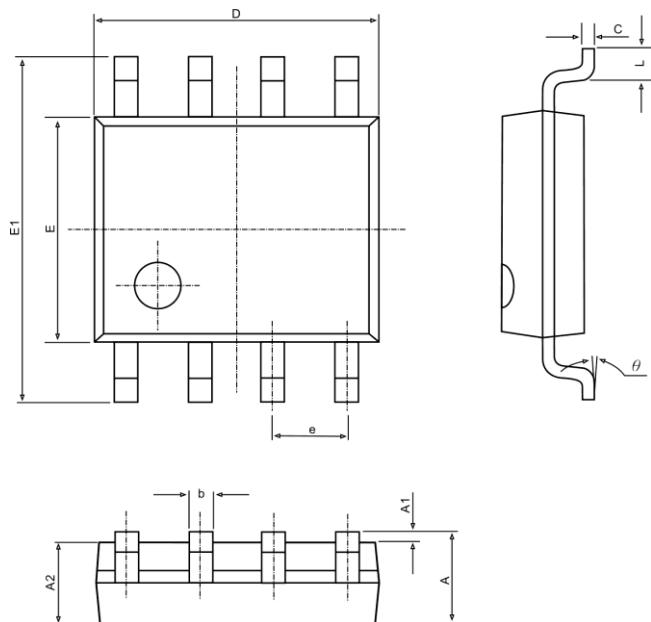


Gate Charge Waveform

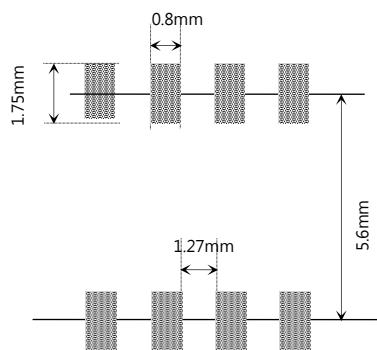


Switching Time Waveform

SOP-8 PACKAGE DIMENSIONS



Recommended Land Pattern



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.300	1.500	0.051	0.059
b	0.390	0.490	0.015	0.019
c	0.200	0.250	0.008	0.010
D	4.800	5.100	0.189	0.201
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 BSC		0.050 BSC	
L	0.500	0.800	0.020	0.031
Θ	0°	8°	0°	8°